

# N-Channel 500V (D-S)Power MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	500				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V 0.660				
Q <sub>g</sub> (Max.) (nC)	81				
Q <sub>gs</sub> (nC)	20				
Q <sub>gd</sub> (nC)	36				
Configuration	Single	9			

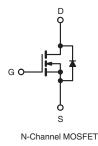
#### **FEATURES**

- Lower Gate Charge  $\mathsf{Q}_g$  Results in Simpler Drive Reqirements



- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage
- Compliant to RoHS Directive 2002/95/EC





ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub>	= 25 °C, unl	ess otherwis	se noted)		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V <sub>DS</sub>	500	v
Gate-Source Voltage			V <sub>GS</sub>	± 20	- V
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	I <sub>D</sub>	13	
	VGS at TO V	T <sub>C</sub> = 100 °C		8.1	A
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	50	
Linear Derating Factor				2.0	W/°C
Single Pulse Avalanche Energy <sup>b</sup>		E <sub>AS</sub>	560	mJ	
Avalanche Current <sup>a</sup>		I <sub>AR</sub>	13	А	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	25	mJ
Maximum Power Dissipation $T_{C} = 25 \text{ °C}$		P <sub>D</sub>	250	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	9.2	V/ns
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) for 10 s			300 <sup>d</sup>		
Mounting Torque	6-32 or M3 screw			10	lbf · in
Mounting Torque				1.1	N · m

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T<sub>J</sub> = 25 °C, L = 5.7 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> =14 A, dV/dt = 7.6 V/ns (see fig. 12a). c. I<sub>SD</sub> ≤ 14 A, dI/dt ≤ 250 A/µs, V<sub>DD</sub> ≤ V<sub>DS</sub>, T<sub>J</sub> ≤ 150 °C.

d. 1.6 mm from case.

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62		
Case-to-Sink, Flat, Greasd Surface	R <sub>thCS</sub>	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.50		

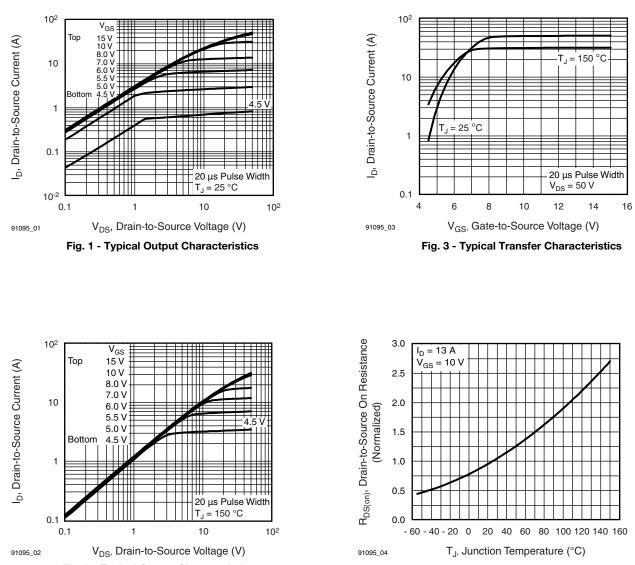
<b>SPECIFICATIONS</b> ( $T_J = 25 \text{ °C}$ , u	nless otherw	vise noted)					
PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static		·					
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub>	= 0 V, I <sub>D</sub> = 250 μA	500	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	e to 25 °C, I <sub>D</sub> = 1 mA	-	0.55	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$		2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		$V_{GS} = \pm 20V$	-	-	±100	nA
Zava Cata Valtaga Drain Current		V <sub>DS</sub> =	$V_{DS} = 500 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	25	
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 400 \	/, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 V$	$I_D = 8.4 \text{ A}^{b}$	-	0.660	-	Ω
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub>	= 50 V, I <sub>D</sub> = 8.4 A	8.1	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0 V$ ,	-	1910	-	
Output Capacitance	C <sub>oss</sub>	]	$V_{GS} = 0.V,$ $V_{DS} = 25 V,$ f = 1.0 MHz, see fig. 5		290	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1			11	-	
	2		V <sub>DS</sub> = 1.0 V, f = 1.0 MHz	-	2730	-	pF
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 V$	V <sub>DS</sub> = 400 V, f = 1.0 MHz	-	82	-	
Effective Output Capacitance	C <sub>oss</sub> eff.	1	V <sub>DS</sub> = 0 V to 400 V <sup>c</sup>	-	160	-	
Total Gate Charge	Qg			-	-	81	
Gate-Source Charge	Q <sub>gs</sub>	1	$I_D = 14 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and $13^{\text{b}}$	-	-	20	nC
Gate-Drain Charge	Q <sub>gd</sub>	1		-	-	36	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{GS} = 10 V$		-	15	-	
Rise Time	t <sub>r</sub>	1	$V_{DD} = 250 \text{ V}, \text{ I}_{D} = 14 \text{ A},$	-	39	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>	1	$R_g = 7.5 \Omega$ , see fig. 10 <sup>b</sup>	-	39	-	
Fall Time	t <sub>f</sub>	1	see fig. 10 <sup>b</sup> - 39 - 31		31	-	1
Drain-Source Body Diode Characteristic	cs						
Continuous Source-Drain Diode Current	IS	MOSFET sym showing the	MOSFET symbol		-	13	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral revers p - n junction		-	-	56	
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C	$I_{S} = 14 \text{ A}, V_{GS} = 0 \text{ V}^{b}$	-	-	1.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			-	370	550	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>		25 °C, I <sub>F</sub> = 14 A, °C, dl/dt = 100 A/μs <sup>b</sup>	-	4.4	6.5	μC
Body Diode Reverse Recovery Current	I <sub>RRM</sub>	1, 1, 1, 2, 1, 2, 3	0, 4, 4, - 100 / 100	-	21	31	Α
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	rn-on time is negligible (turn	-on is doi	minated b	y L <sub>S</sub> and	L <sub>D</sub> )

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %. c. C<sub>oss</sub> eff. is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 % to 80 % V<sub>DS</sub>.





#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)







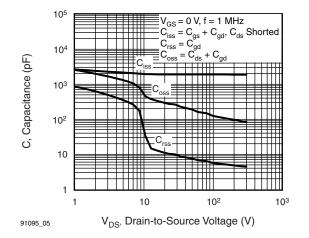


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

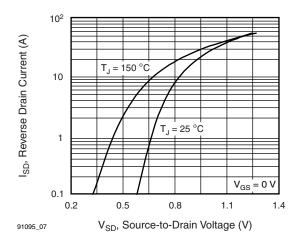


Fig. 7 - Typical Source-Drain Diode Forward Voltage

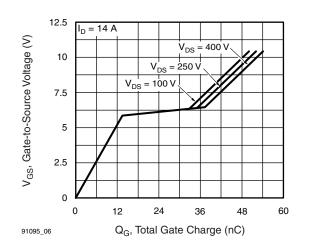


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

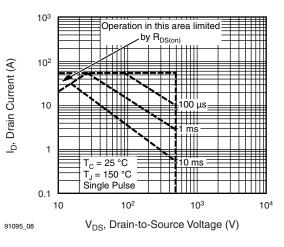


Fig. 8 - Maximum Safe Operating Area



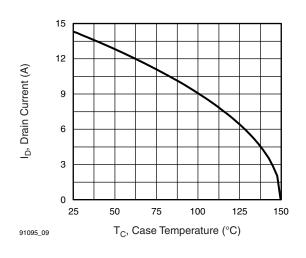


Fig. 9 - Maximum Drain Current vs. Case Temperature

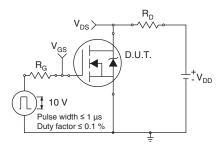


Fig. 10a - Switching Time Test Circuit

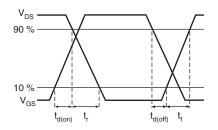


Fig. 10b - Switching Time Waveforms

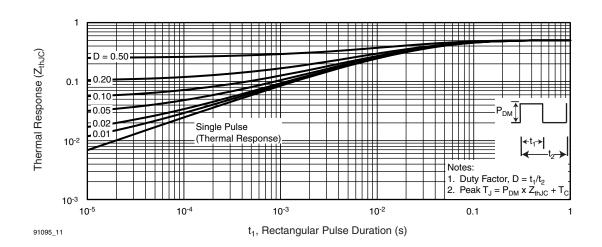


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



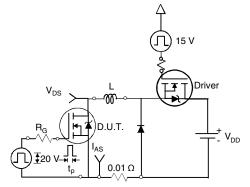


Fig. 12a - Unclamped Inductive Test Circuit

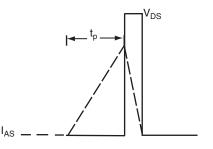


Fig. 12b - Unclamped Inductive Waveforms

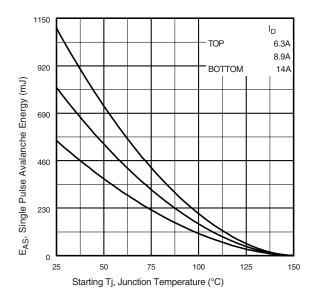


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

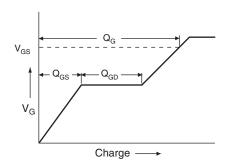


Fig. 13a - Basic Gate Charge Waveform

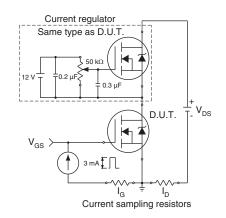
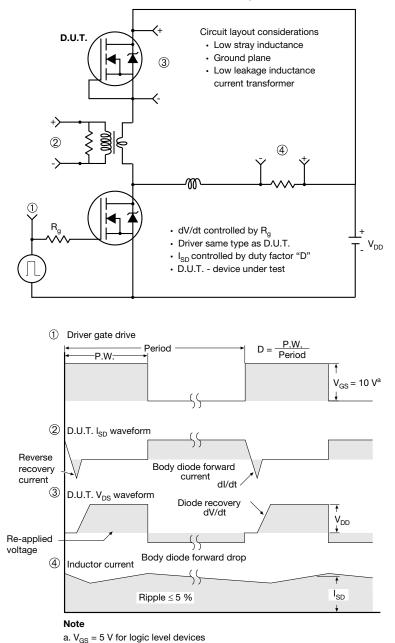


Fig. 13b - Gate Charge Test Circuit



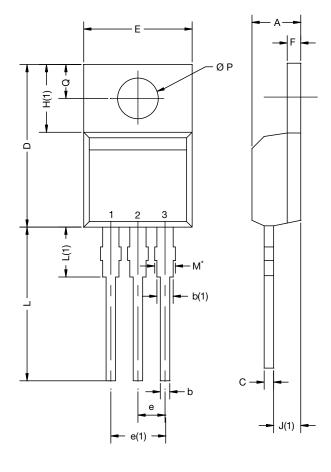


Peak Diode Recovery dV/dt Test Circuit

Fig. 14 - For N-Channel



# **TO-220AB**



DIM	MILLIN	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.24	4.65	0.167	0.183	
b	0.69	1.02	0.027	0.040	
b(1)	1.14	1.78	0.045	0.070	
С	0.36	0.61	0.014	0.024	
D	14.33	15.85	0.564	0.624	
E	9.96	10.52	0.392	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.10	6.71	0.240	0.264	
J(1)	2.41	2.92	0.095	0.115	
L	13.36	14.40	0.526	0.567	
L(1)	3.33	4.04	0.131	0.159	
ØР	3.53	3.94	0.139	0.155	
Q	2.54	3.00	0.100	0.118	
ECN: X15- DWG: 603	0364-Rev. C, 1	14-Dec-15			

Note

-  $M^{\star}$  = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



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